


Search Notes 	Application/Control No. 10565106	Applicant(s)/Patent Under Reexamination HAN ET AL.
	Examiner M. Lee	Art Unit 2622

SEARCHED			
Class	Subclass	Date	Examiner
348	515, 518, 484, 194	5/5/09	ml

SEARCH NOTES		
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INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
	Interference search history attached.	5/5/09	ml

	/M. Lee/ Primary Examiner.Art Unit 2622
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